

# $\mu$ PA2593

# MOS FIELD EFFECT TRANSISTOR

R07DS0012EJ0200 Rev.2.00 Sep 10, 2010

## **Description**

The  $\mu$ PA2593 is N- and P-channel MOSFETs designed for DC/DC converters and power management applications of portable equipments.

N- and P-channel MOSFETs are assembled in one package, to contribute minimize the equipments.

#### **Features**

- 4.5 V drive available
- Low on-state resistance

N-channel

- ---  $R_{DS(on)1} = 58 \text{ m}\Omega \text{ MAX.}$  ( $V_{GS} = 10 \text{ V}$ ,  $I_D = 2 \text{ A}$ )
- ---  $R_{DS(on)2}$  = 103 mΩ MAX. ( $V_{GS}$  = 4.5 V,  $I_D$  = 2 A)

P-channel

- ---  $R_{DS(on)1}$  = 140 mΩ MAX. ( $V_{GS}$  = -10 V,  $I_D$  = -2 A)
- ---  $R_{DS(on)2}$  = 195 mΩ MAX. ( $V_{GS}$  = -4.5 V,  $I_D$  = -2 A)
- Built-in gate protection diode
- Small and surface mount package (8-pin VSOF (2429))

## **Ordering Information**

Part No.	LEAD PLATING	PACKING	Package
μ PA2593T1H-T1-AT *1	Pure Sn (Tin)	8 mm embossed taping	8-pin VSOF (2429)
μ PA2593T1H-T2-AT *1		3000 p/reel	

Note: \*1. Pb-free (This product does not contain Pb in the external electrode and other parts.)

Marking: 2593

## Absolute Maximum Ratings $(T_A = 25^{\circ}C)$

Item	Symbol	N-CHANNEL	P-CHANNEL	Unit
Drain to Source Voltage (V <sub>GS</sub> = 0 V)	$V_{DSS}$	40	-40	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	$V_{GSS}$	±18	∓18	V
Drain Current (DC)	I <sub>D(DC)</sub>	±4.5	∓3.5	А
Drain Current (pulse) *1	I <sub>D(pulse)</sub>	±18	∓18	А
Total Power Dissipation (1 unit, 5 s) *2	P <sub>T1</sub>	1.5		W
Total Power Dissipation (2 unit, 5 s) *2	P <sub>T2</sub>	1.24		W
Channel Temperature	T <sub>ch</sub>	150		°C
Storage Temperature	T <sub>stg</sub>	−55 to	°C	

Notes: \*1. PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

\*2. Mounted on FR-4 board of 25.4 mm x 25.4 mm x 0.8 mmt

# Electrical Characteristics ( $T_A = 25^{\circ}C$ )

#### **N-channel MOSFET**

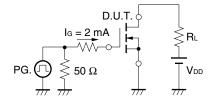
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			1	μΑ	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$
Gate Leakage Current	I <sub>GSS</sub>			±10	μΑ	$V_{GS} = \pm 14 \text{ V}, V_{DS} = 0 \text{ V}$
Gate Cut-off Voltage	$V_{GS(off)}$	1.0		2.5	V	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$
Forward Transfer Admittance *1	y <sub>fs</sub>	2.0			S	$V_{DS} = 5 \text{ V}, I_{D} = 2 \text{ A}$
Drain to Source On-state	R <sub>DS(on)1</sub>		50	58	mΩ	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A
Resistance *1	R <sub>DS(on)2</sub>		70	103	mΩ	$V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$
Input Capacitance	C <sub>iss</sub>		315		pF	V <sub>DS</sub> = 10 V,
Output Capacitance	Coss		70		pF	$V_{GS} = 0 V$ ,
Reverse Transfer Capacitance	C <sub>rss</sub>		38		pF	f = 1 MHz
Turn-on Delay Time	$t_{d(on)}$		5		ns	$V_{DD} = 20 \text{ V}, I_D = 2 \text{ A},$
Rise Time	t <sub>r</sub>		3		ns	$V_{GS} = 10 V,$
Turn-off Delay Time	$t_{d(off)}$		21		ns	$R_G = 6 \Omega$
Fall Time	t <sub>f</sub>		3		ns	
Total Gate Charge	$Q_G$		7		nC	$V_{DD} = 32 \text{ V}, V_{GS} = 10 \text{ V}$
						I <sub>D</sub> = 4.5 A
Body Diode Forward Voltage *1	$V_{F(S-D)}$		0.9		V	I <sub>F</sub> = 4.5 A, V <sub>GS</sub> = 0 V

Note: \*1. Pulsed

#### **TEST CIRCUIT 1 SWITCHING TIME**

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#### TEST CIRCUIT 2 GATE CHARGE



#### **P-channel MOSFET**

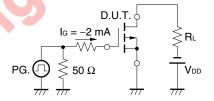
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			-1	μΑ	$V_{DS} = -40 \text{ V}, V_{GS} = 0 \text{ V}$
Gate Leakage Current	I <sub>GSS</sub>			∓10	μΑ	$V_{GS} = \mp 14 \text{ V}, V_{DS} = 0 \text{ V}$
Gate Cut-off Voltage	$V_{GS(off)}$	-1.0		-2.5	V	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$
Forward Transfer Admittance *1	y <sub>fs</sub>	2.0			S	$V_{DS} = -5 \text{ V}, I_{D} = -2 \text{ A}$
Drain to Source On-state	R <sub>DS(on)1</sub>		115	140	mΩ	$V_{GS} = -10 \text{ V}, I_D = -2 \text{ A}$
Resistance *1	R <sub>DS(on)2</sub>		135	195	mΩ	$V_{GS} = -4.5 \text{ V}, I_D = -2 \text{ A}$
Input Capacitance	C <sub>iss</sub>		350		pF	$V_{DS} = -10 \text{ V},$
Output Capacitance	Coss		60		pF	$V_{GS} = 0 V$ ,
Reverse Transfer Capacitance	C <sub>rss</sub>		47		pF	f = 1 MHz
Turn-on Delay Time	t <sub>d(on)</sub>		5.5		ns	$V_{DD} = -20 \text{ V}, I_{D} = -2 \text{ A},$
Rise Time	t <sub>r</sub>		3.5		ns	$V_{GS} = -10 \text{ V},$
Turn-off Delay Time	t <sub>d(off)</sub>		40		ns	$R_G = 6 \Omega$
Fall Time	t <sub>f</sub>		8		ns	
Total Gate Charge	$Q_G$		8		nC	$V_{DD} = -32 \text{ V}, V_{GS} = -10 \text{ V}$
						$I_D = -3.5 \text{ A}$
Body Diode Forward Voltage *1	$V_{F(S-D)}$		0.95		V	$I_F = -3.5 \text{ A}, V_{GS} = 0 \text{ V}$

Note: \*1. Pulsed

#### **TEST CIRCUIT 1 SWITCHING TIME**

# PG. $\bigcirc$ $V_{GS}$ $V_{GS$

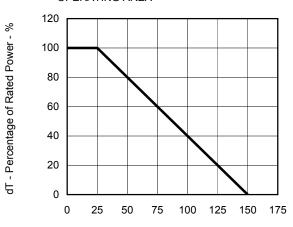
## TEST CIRCUIT 2 GATE CHARGE



## Typical Characteristics ( $T_A = 25^{\circ}C$ )

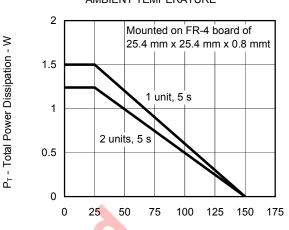
#### (1) N-channel MOSFET

DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



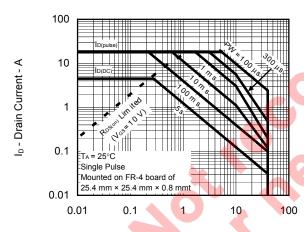
T<sub>A</sub> - Ambient Temperature - °C

# TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



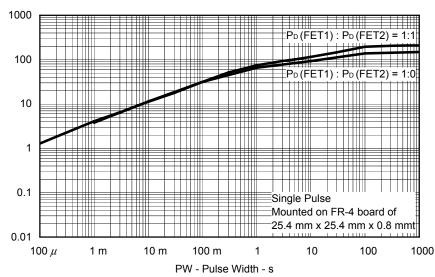
T<sub>A</sub> - Ambient Temperature - °C

#### FORWARD BIAS SAFE OPERATING AREA



V<sub>DS</sub> - Drain to Source Voltage - V

#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



#### DRAIN CURRENT vs. FORWARD TRANSFER CHARACTERISTICS DRAIN TO SOURCE VOLTAGE 25 10 T<sub>ch</sub> = -50°C -25°C 20 I<sub>D</sub> - Drain Current - A 1 I<sub>D</sub> - Drain Current - A 0°C 25°C V<sub>GS</sub> = 10 V 15 75°C 0.1 125°C 4.5 V 10 150°C 0.01 5 V<sub>DS</sub> = 10 V Pulsed Pulsed 0.001 0 0.5 1 0 2 3 5 0 1.5 1 4 $V_{\text{DS}}$ - Drain to Source Voltage - V $V_{\text{GS}}$ - Gate to Source Voltage - VGATE CUT-OFF VOLTAGE vs. FORWARD TRANSFER ADMITTANCE vs. DRAIN CHANNEL TEMPERATURE CURRENT 10 y<sub>fs</sub> | - Forward Transfer Admittance - S -55°C V<sub>GS(off)</sub> - Gate Cut-off Voltage - V 3 125°C 2 1 Vps = 10 V /<sub>DS</sub> = 5 $I_D = 1 \text{ mA}$ Pulsed 0 -75 -25 25 75 125 175 0.01 0.1 10 T<sub>ch</sub> - Channel Temperature - °C ID - Drain Current - A DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN TO SOURCE ON-STATE RESISTANCE vs. **DRAIN CURRENT** GATE TO SOURCE VOLTAGE $R_{\text{DS(on)}}$ - Drain to Source On-state Resistance - $m\Omega$ $R_{\text{DS(on)}}$ - Drain to Source On-state Resistance - $m\Omega$ 120 120 $I_D = 2 A$ Pulsed Pulsed 100 100 80 80 60 60 10 V 40 40 20 20 0 0 0.1 1 10 0 5 10 15 20 100

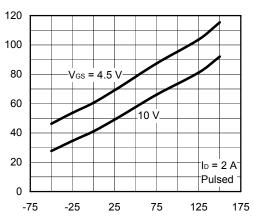
ID - Drain Current - A

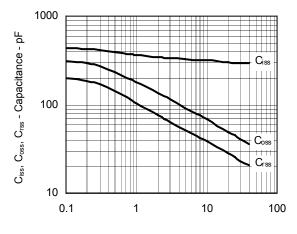
 $V_{\text{GS}}$  - Gate to Source Voltage - V

 $R_{\text{DS(on)}}$  - Drain to Source On-state Resistance -  $m\Omega$ 

V<sub>DS</sub> - Drain to Source Voltage - V

IF - Diode Forward Current - A

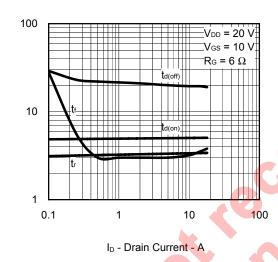




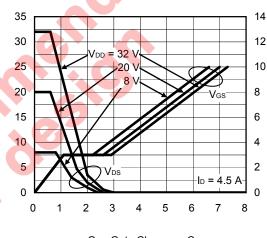
V<sub>DS</sub> - Drain to Source Voltage - V

# SWITCHING CHARACTERISTICS

 $T_{\text{ch}}$  - Channel Temperature -  $^{\circ}C$ 

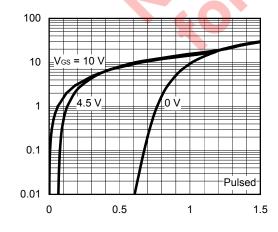


#### DYNAMIC INPUT/OUTPUT CHARACTERISTICS



Q<sub>G</sub> - Gate Charge - nC

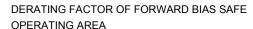
#### SOURCE TO DRAIN DIODE FORWARD VOLTAGE

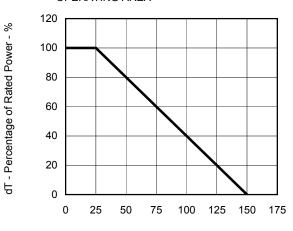


 $V_{F(S-D)}$  - Source to Drain Voltage - V

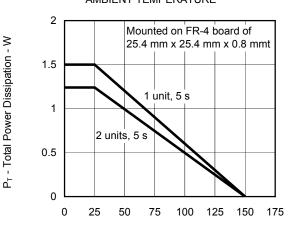
V<sub>DS</sub> - Drain to Source Voltage - V

## (2) P-channel MOSFET





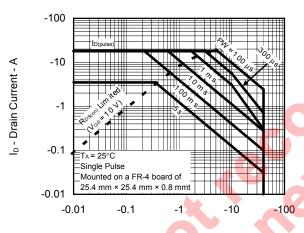
# TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



#### TA - Ambient Temperature - °C

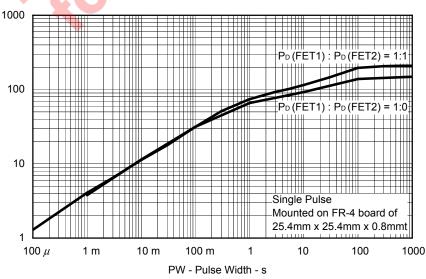
## $T_{\text{A}}$ - Ambient Temperature - $^{\circ}\text{C}$

#### FORWARD BIAS SAFE OPERATING AREA



V<sub>DS</sub> - Drain to Source Voltage - V

#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

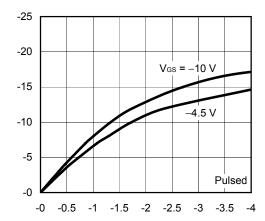


I<sub>D</sub> - Drain Current - A

V<sub>GS(off)</sub> - Gate Cut-off Voltage - V

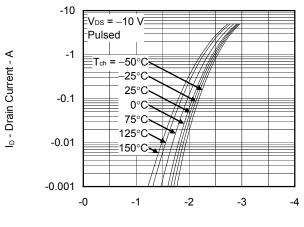
 $R_{\text{DS}(\text{on})}$  - Drain to Source On-state Resistance -  $m\Omega$ 

# DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



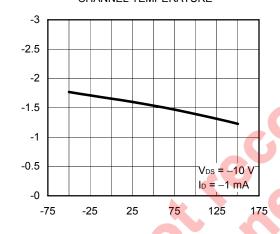
 $V_{\text{DS}}$  - Drain to Source Voltage - V

#### FORWARD TRANSFER CHARACTERISTICS



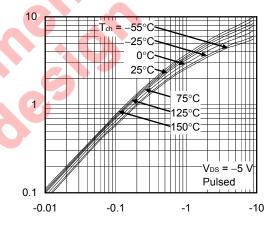
V<sub>GS</sub> - Gate to Source Voltage - V

# GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



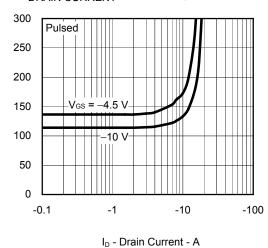
T<sub>ch</sub> - Channel Temperature - °C

# FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

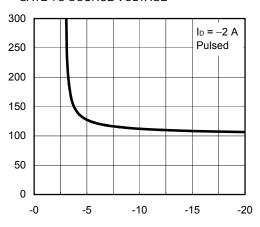


I<sub>D</sub> - Drain Current - A

# DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



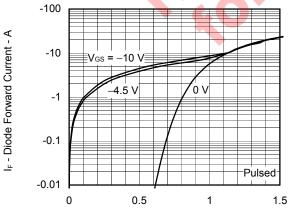
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



V<sub>GS</sub> - Gate to Source Voltage - V

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  - Drain to Source On-state Resistance -  $m\Omega$ 

y<sub>fs</sub> | - Forward Transfer Admittance - S

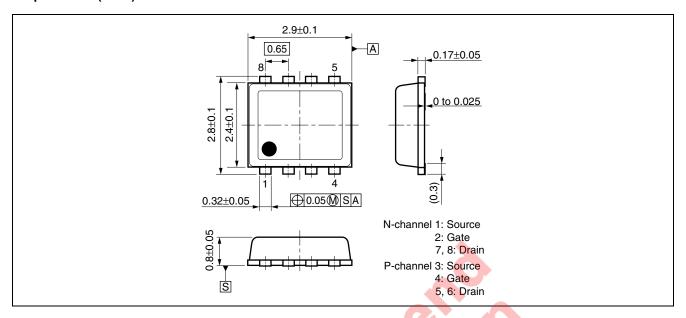


 $V_{F(S\text{-}D)}$  - Source to Drain Voltage - V

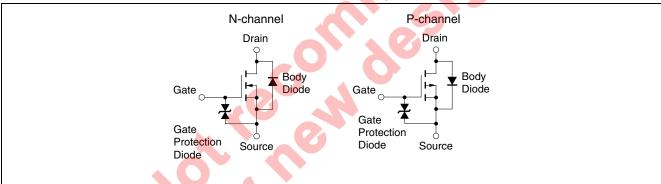
V<sub>GS</sub> - Gate to Source Voltage - V

## Package Drawings (Unit: mm)

#### 8-pin VSOF (2429)



## **Equivalent Circuit**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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### $\mu$ PA2593

		Description		
Rev.	Date	Page	Summary	
1.00	Jul 01, 2010	-	First Eddition Issued	
2.00	Sep 10,2010	5, 6	Change of graphs	



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